

### • General Description

The AGM85P10AP combines advanced trench MOSFET technology with a low resistance package to provide extremely low  $R_{\text{DS(ON)}}$ .

This device is ideal for load switch and battery protection applications.

#### Features

- Advance high cell density Trench technology
- Low R<sub>DS(ON)</sub> to minimize conductive loss
- Low Gate Charge for fast switching
- Low Thermal resistance
- 100% Avalanche tested
- 100% DVDS tested

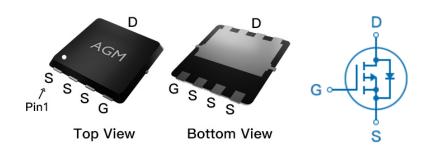
## Application

- MB/VGA Vcore
- SMPS 2<sup>nd</sup> Synchronous Rectifier
- POL application
- BLDC Motor driver

## **Product Summary**

BVDSS	RDSON	ID		
-100V	86mΩ	-19A		

PDFN3.3\*3.3 Pin Configuration



#### **Package Marking and Ordering Information**

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
AGM85P10AP	AGM85P10AP	PDFN3.3*3.3	330mm	12mm	3000

### Table 1. Absolute Maximum Ratings (TA=25℃)

Symbol	Parameter	Value	Unit
VDS	Drain-Source Voltage (VGS=0V)	-100	V
VGS	Gate-Source Voltage (VDS=0V)	±20	V
ID	Drain Current-Continuous(Tc=25℃) (Note 1)	-19	Α
שו	Drain Current-Continuous(Tc=100℃)	-13.5	А
IDM (pluse)	Drain Current-Pulsed (Note 2)	-76	Α
	Maximum Power Dissipation(Tc=25℃)	79	w
PD	Maximum Power Dissipation(Tc=100℃)	39	w
EAS	Avalanche energy (Note 3)	156	mJ
TJ,TSTG	Operating Junction and Storage Temperature Range	-55 To 175	${\mathbb C}$

#### Table 2. Thermal Characteristic

Symbol	Parameter	Тур	Max	Unit
RθJA	Thermal Resistance Junction-ambient (Steady State) <sup>1</sup>		50	°C/W
RøJC	Thermal Resistance Junction-Case <sup>1</sup>		1.9	°C/W



Table 3. Electrical Characteristics (TJ=25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
On/Off Sta	ites					
BVDSS	Drain-Source Breakdown Voltage	VGS=0V ID=-250μA	-100			V
IDSS	Zero Gate Voltage Drain Current	VDS=-100V,VGS=0V			-1	μΑ
IGSS	Gate-Body Leakage Current	VGS=±20V,VDS=0V			±100	nA
VGS(th)	Gate Threshold Voltage	VDS=VGS,ID=-250µA	-1.2	-1.5	-2.2	V
gFS	Forward Transconductance	VDS=-5V,ID=-8A		23		S
RDS(on)	Drain-Source On-State Resistance	VGS=-10V, ID=-10A		86	103	mΩ
1.23(611)		VGS=-4.5V, ID=-8A		90	106	mΩ
Dynamic C	Characteristics					
Ciss	Input Capacitance	VDS=-40V,VGS=0V		3700		pF
Coss	Output Capacitance	,F=1MHZ		90		pF
Crss	Reverse Transfer Capacitance			32		pF
Rg	Gate resistance	VGS=0V, VDS=0V,f=1.0MHz		22	-	Ω
Switching	Times					
td(on)	Turn-on Delay Time			6.0		nS
tr	Turn-on Rise Time	VGS=-10V,VDS=-50V,		29		nS
td(off)	Turn-Off Delay Time	RL=5Ω,RGEN=9.1Ω		17		nS
tf	Turn-Off Fall Time			24		nS
Qg	Total Gate Charge			72		nC
Qgs	Gate-Source Charge	VGS=-10V, VDS=-50V, ID=-10A		8.4		nC
Qgd	Gate-Drain Charge	- VDG=-30V, ID=-10/A		17.3		nC
Source-Dr	ain Diode Characteristics					
ISD	Source-Drain Current(Body Diode)				-19	Α
VSD	Forward on Voltage	VGS=0V,IS=-10A			-1.2	V
trr	Reverse Recovery Time	Isd=-10A ,		32		ns
Qrr	Reverse Recovery Charge	dl/dt=100A/µs , TJ=25℃		53		nc

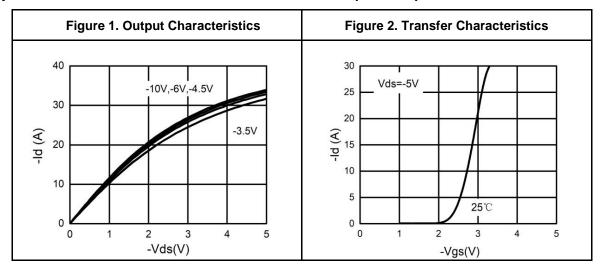
Notes 1. The maximum current rating is package limited.

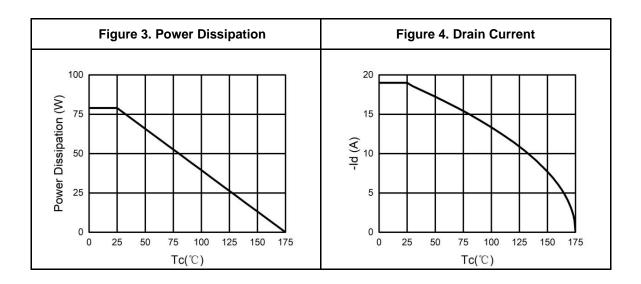
Notes 2. Repetitive Rating: Pulse width limited by maximum junction temperature

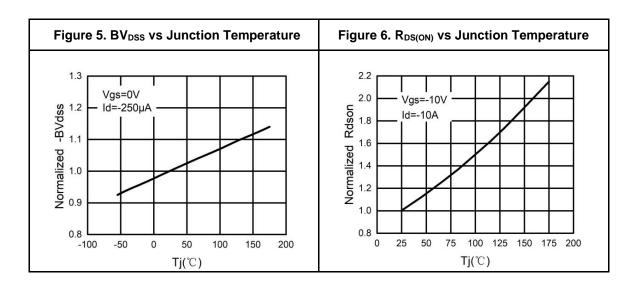
Notes 3.EAS condition: TJ=25  $^{\circ}$ C,VDD=-50V,Vgs=-10V,ID=-25A,L=0.5mH,RG=25ohm



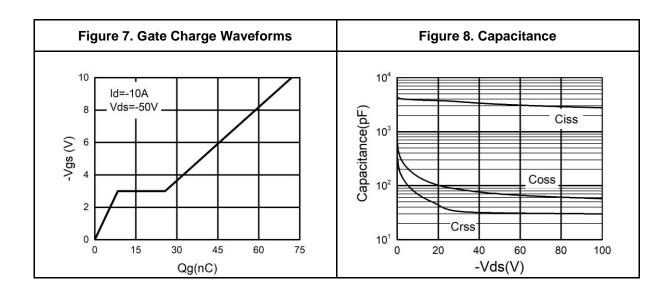
# **Typical Electrical And Thermal Characteristics (Curves)**

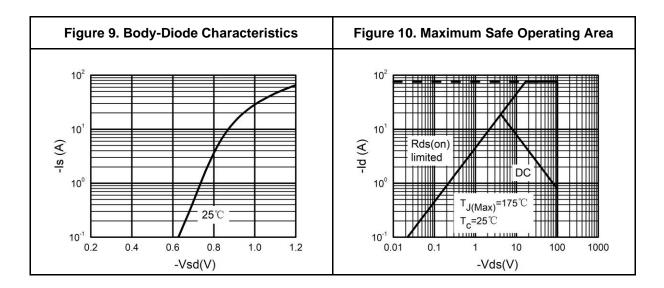








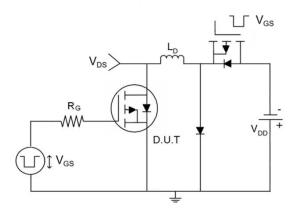


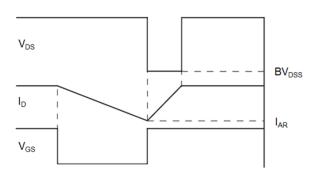




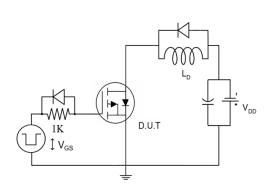
## **Test Circuit**

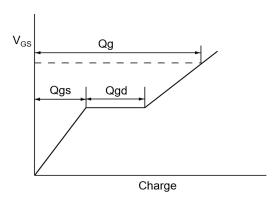
# 1) E<sub>AS</sub> Test Circuits



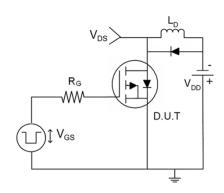


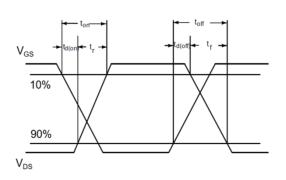
## 2) Gate Charge Test Circuit





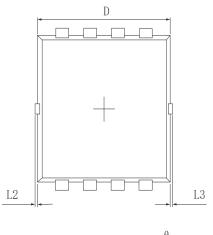
## 3) Switch Time Test Circuit

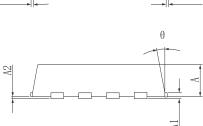


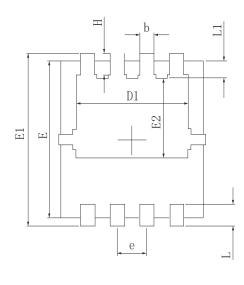




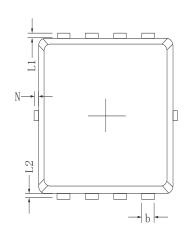
# •Dimensions (PDFN3.3\*3.3)

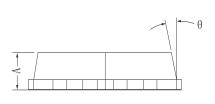


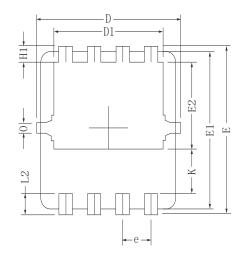


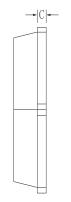


CAMBOI	MILLIMETER			
SYMBOL	MIN	Тур.	MAX	
A	0.700	0.800	0.900	
A1	0.	152REF	`.	
A2		0~0.05		
D	3.000	3. 100	3. 200	
D1	2.300	2. 450	2.600	
Е	2.900	3.000	3. 100	
E1	3. 150	3. 300	3.450	
E2	1.320	1.520	1.720	
b	0.200	0.300	0.400	
е	0.550	0.650	0.750	
L	0.300	0.400	0.500	
L1	0.180	0.330	0.480	
L2	0~0.100			
L3	0~0.100			
Н	0.315	0.415	0.515	
θ	8°	10°	12°	





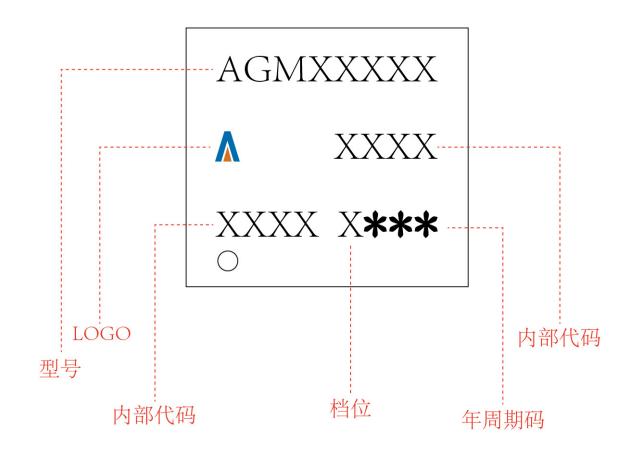




	Millimeters			
Symbols	MIN.	NOM.	MAX.	
A	0.65	0.75	0.85	
b	0.25	0.30	0.35	
С	0.15	0.20	0.25	
D	3.00	3. 10	3.20	
D1	2.40	2.50	2.60	
Е	3. 20	3. 30	3.40	
E1	3.00	3. 10	3.20	
E2	1.60	1.70	1.80	
е	0.	65 BSC	· ·	
H1	0.21	0.31	0.41	
Н2	0.30	0.40	0.50	
K	0.78	0.88	0.98	
L1/L2	0.10 REF.			
θ	11°	12°	13°	
N	0	_	0.15	
0	0.2 REF.			



# PDFN3.3\*3.3 Marking Instructions:





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